

ID	R <sub>Ds</sub> (ON)(Typ)	VDSS
180A	3mΩ	100V
• 100% a	: vitching speed avalanche tested ved dv/dt capability	

#### **Ordering Information**

Part Number	Package	Marking	Packing	Qty.
RS100N180T	T0-220	RS100N180T	Tube	50 PCS

#### Absolute Maximun Ratings Tc= $25^{\circ}$ unless otherwise specified

Symbol	Parameter	RS100N180T	Units
VDSS	Drain-to-Source Voltage	100	V
ID	Continuous Drain Current TC=25℃	180	
ID	Continuous Drain Current TC=100℃	112	А
IDM	Pulsed Drain Current	480	
PD	Power Dissipation	223	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH,IS = 45A, RG = 25Ω, Tj = 25℃	511	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

\* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



### **Thermal Resistance**

Symbol	Parameter	RS100N180T	Units	Test Conditions
RØJC	Junction-to-Case	0.56	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}$ C
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

# **OFF Characteristics** TJ= 25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	100			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=100V,VGS= 0V
	Gate- to- Source Forward Leakage			100	~ ^	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

# **ON Characteristics** TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		3	3.8	mΩ	VGS=10V,ID=90A
VGS(TH )	Gate Threshold Voltage	2.2		3.8	V	VGS=VDS,ID=25 0μA

# **Resistive Switching Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		35		- nS	VDS=50V ID=90A RG=3Ω VGS=10V
trise	Rise Time		111			
td(OFF)	Turn- OFF Delay Time		84			
tfall	Fall Time		112			VG2-10V



#### **Dynamic Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		8140			VGS= 0V
Coss	Output Capacitance		1850		pF	VDS=40V
Crss	Reverse Transfer Capacitance		190			f=1MHz
Qg	Total Gate Charge		169			VDS= 50V
Qgs	Gate- to- Source Charge		67		nC	ID=90A
Qgd	Gate-to-Drain(" Miller") Charge		30			VGS=10V

#### **Source- Drain Diode Characteristics**

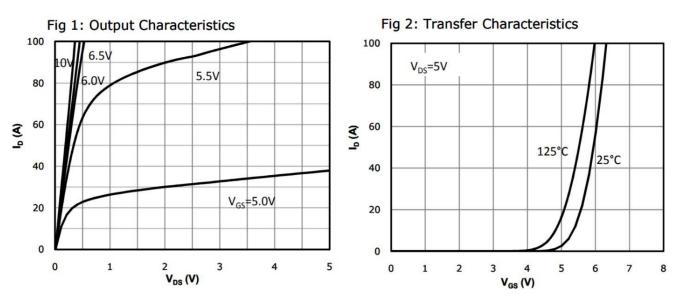
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			180	А	Integral pn- diode	
ISM	Maximum Pulsed Current			480	Α	in MOSFET	
VSD	Diode Forward Voltage			1.4	V	IS=20A,VGS=0V	
trr	Reverse Recovery Time		101		nS	VGS=0V	
Qrr	Reverse Recovery Charge		338		nC	IS=24A di/dt=100A/μs	

Notes:

\* 1. Repetitive rating, pulse width limited by maximum junction temperature.

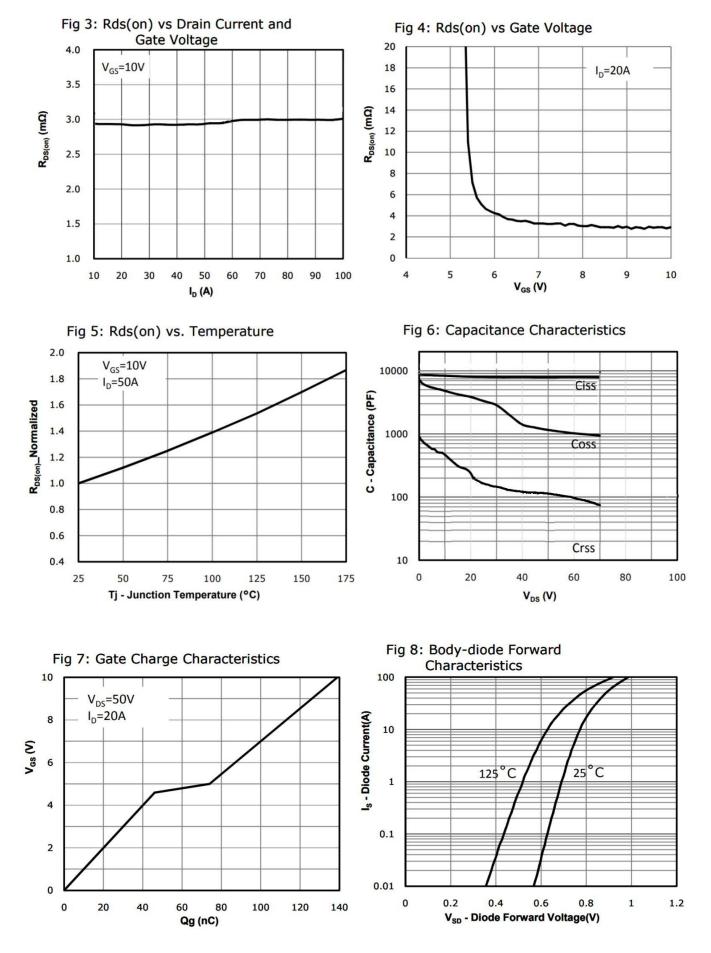
\* 2. Pulse Test: Pulse width  $\leq$  300µs, Duty Cycle  $\leq$  1%

# **Typical Feature Curve**

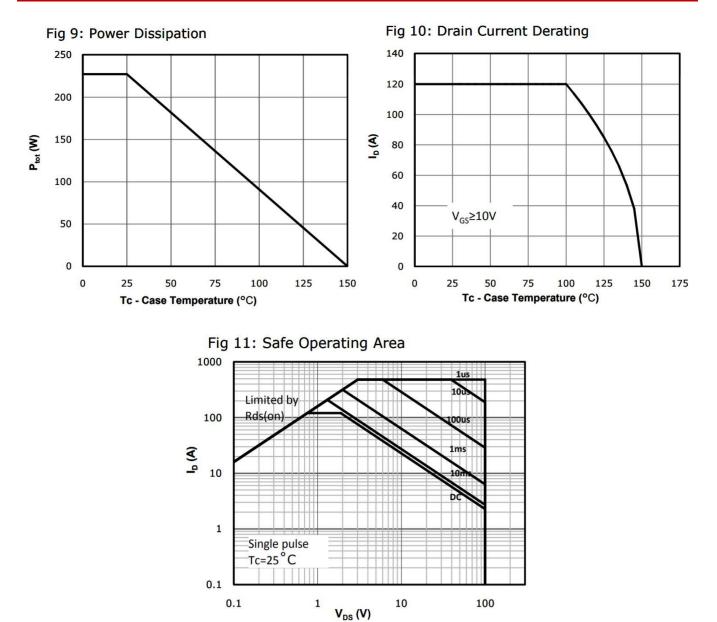


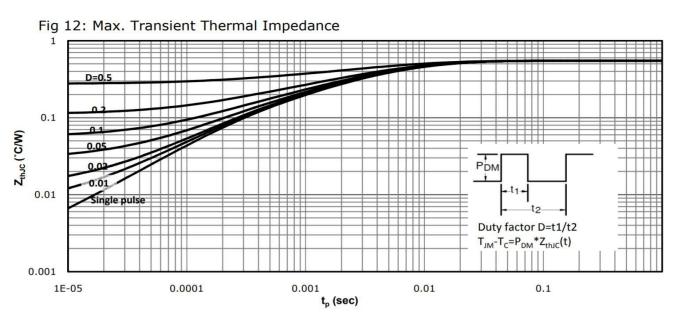
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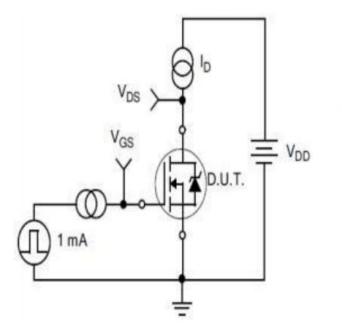




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# Test ircuits and Waveforms



VGS(TH)

VDS

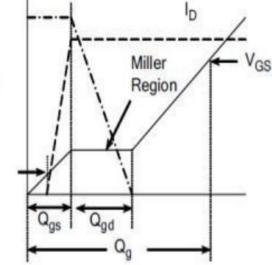


Figure A. Gate Charge Test Circuit

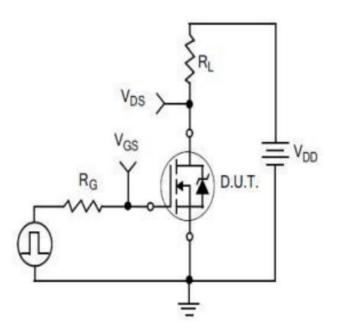


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

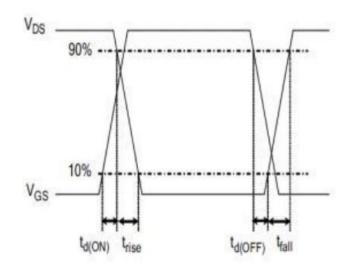
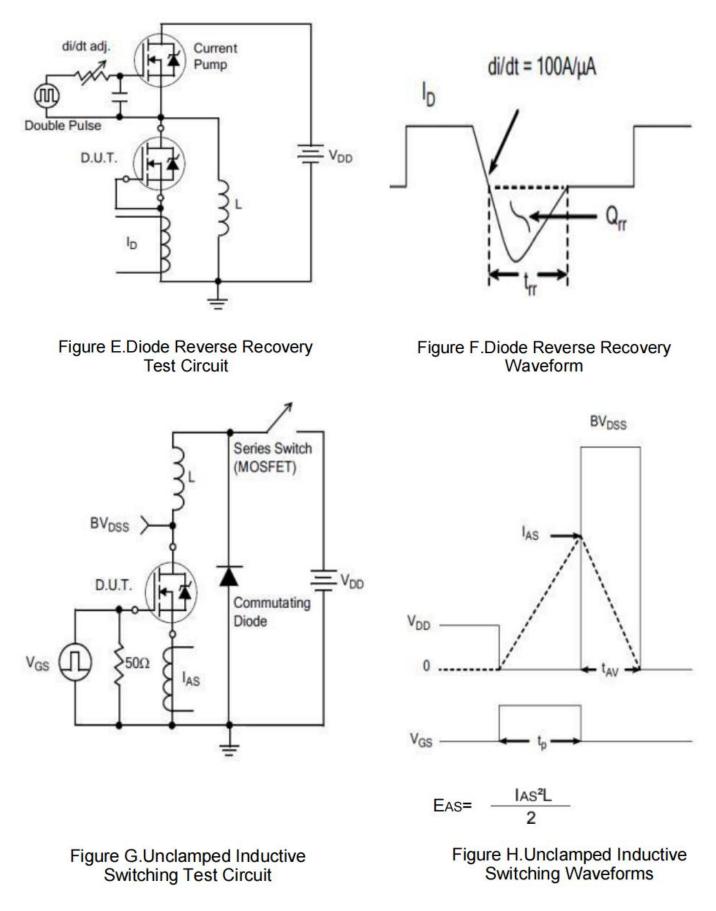


Figure D. Resistive Switching Waveforms

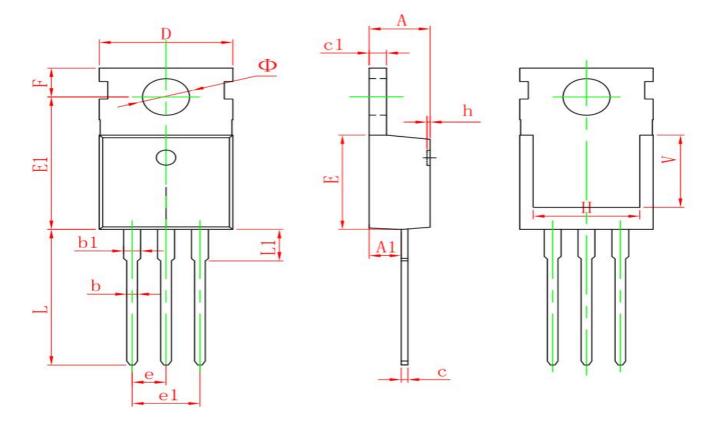


# Test ircuits and Waveforms





# Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s in inches
Symbol	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
е	2.540	TYP.	0.100	TYP.
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
Н	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	6.900	REF.	0.276 REF.	
Φ	3.400	3.800	0.134	0.150



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